



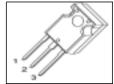
Cool MOS™ Power Transistor

Feature

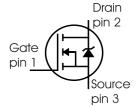
- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- Ultra low effective capacitances
- Improved transconductance
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC⁰⁾ for target applications

V _{DS} @ T _{imax}	560	V
R _{DS(on)}	0.28	Ω
I _D	16	Α





Туре	Package	Ordering Code	Marking
SPW16N50C3	PG-TO247	Q67040-S4584	16N50C3



Maximum Ratings

Parameter	Symbol	Value	Unit
Continuous drain current	I_{D}		Α
$T_{\rm C}$ = 25 °C		16	
$T_{\rm C}$ = 100 °C		10	
Pulsed drain current, t_p limited by T_{jmax}	I _{D puls}	48	
Avalanche energy, single pulse	E _{AS}	460	mJ
$I_{\rm D} = 8 \; , \; V_{\rm DD} = 50 \; {\rm V}$			
Avalanche energy, repetitive t_{AR} limited by T_{jmax} ¹	E _{AR}	0.64	
$I_{\rm D}$ = 16 A, $V_{\rm DD}$ = 50 V			
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I _{AR}	16	Α
Reverse diode dv/dt 4)	dv/dt	15	V/ns
Gate source voltage	V_{GS}	±20	V
Gate source voltage AC (f >1Hz)	V_{GS}	±30	
Power dissipation, $T_{\rm C}$ = 25°C	P _{tot}	160	W
Operating and storage temperature	T _j , T _{stg}	-55 +150	°C





Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope	dv/dt	50	V/ns
$V_{\rm DS}$ = 400 V, $I_{\rm D}$ = 16 A, $T_{\rm j}$ = 125 °C			

Thermal Characteristics

Parameter	Symbol	Values			Unit	
		min.	typ.	max.		
Thermal resistance, junction - case	R _{thJC}	-	-	0.78	K/W	
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62		
Soldering temperature, wavesoldering	T_{sold}	-	-	260	°C	
1.6 mm (0.063 in.) from case for 10s						

Electrical Characteristics, at T_j =25°C unless otherwise specified

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =0.25mA	500	-	-	V
Drain-Source avalanche	V _{(BR)DS}	V _{GS} =0V, I _D =16A	-	600	-	
breakdown voltage	, ,					
Gate threshold voltage	V _{GS(th)}	$I_{\rm D}$ =675 $\mu{\rm A}, V_{\rm GS}$ = $V_{\rm DS}$	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =500V, V _{GS} =0V,				μA
		<i>T</i> _j =25°C,	-	0.1	1	
		<i>T</i> _j =150°C	-	-	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =10A,				Ω
	, ,	<i>T</i> _j =25°C	-	0.25	0.28	
		<i>T</i> _j =150°C		0.68	_	
Gate input resistance	R _G	f=1MHz, open Drain	-	1.5	_	



Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified

Parameter	Symbol	Symbol Conditions		Values		Unit
			min.	typ.	max.	
Transconductance	<i>g</i> fs	$V_{DS} \ge 2*I_{D}*R_{DS(on)max}$	-	14	-	S
		I _D =10A				
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V,	-	1600	-	pF
Output capacitance	Coss	f=1MHz	-	800	-	
Reverse transfer capacitance	C _{rss}		-	30	-	
Effective output capacitance,2)		V _{GS} =0V,	-	64	-	pF
energy related	, ,	V _{DS} =0V to 400V				
Effective output capacitance,3)	C _{o(tr)}		-	124	-	
time related	, ,					
Turn-on delay time	t _{d(on)}	V _{DD} =380V, V _{GS} =0/10V,	-	10	-	ns
Rise time	t _r	$I_{\rm D}$ =16A, $R_{\rm G}$ =4.3 Ω	-	8	-	
Turn-off delay time	t _{d(off)}		-	50	-	
Fall time	<i>t</i> _f		-	8	-	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	V _{DD} =380V, I _D =16A	_	7	-	nC
Gate to drain charge	Q _{gd}		-	36	-	
Gate charge total	Qg	V _{DD} =380V, I _D =16A,	-	66	-	
		V _{GS} =0 to 10V				
Gate plateau voltage	V _(plateau)	V _{DD} =380V, I _D =16A	-	5	1	V

Identical low-side and high-side switch.

⁰J-STD20 and JESD22

¹Repetitve avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} * f$.

 $^{^2}C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

 $^{^3}C_{
m o(tr)}$ is a fixed capacitance that gives the same charging time as $C_{
m oss}$ while $V_{
m DS}$ is rising from 0 to 80% $V_{
m DSS}$.

 $^{^{4}\}text{I}_{\text{SD}}\text{<=I}_{\text{D}}\text{, di/dt}\text{<=400A/us, V}_{\text{DClink}}\text{=400V, V}_{\text{peak}}\text{<V}_{\text{BR, DSS}}\text{, T}_{j}\text{<T}_{j}\text{,max.}$

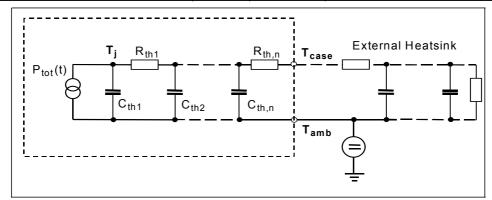


Electrical Characteristics, at T_i = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	1
Inverse diode continuous	IS	<i>T</i> _C =25°C	-	-	16	Α
forward current						
Inverse diode direct current,	I _{SM}		-	-	48]
pulsed						
Inverse diode forward voltage	V_{SD}	V_{GS} =0V, I_F = I_S	-	1	1.2	V
Reverse recovery time	$t_{\rm rr}$	V_{R} =380V, I_{F} = I_{S} ,	-	420	-	ns
Reverse recovery charge	Q _{rr}	d <i>i</i> _F /d <i>t</i> =100A/μs	-	7	-	μC
Peak reverse recovery current	<i>I</i> _{rrm}		-	40	-	Α
Peak rate of fall of reverse	di _{rr} /dt			tbd	-	A/µs
recovery current						

Typical Transient Thermal Characteristics

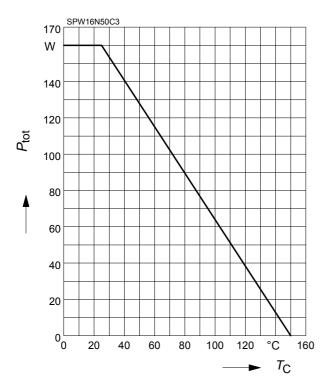
Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
Thermal r	esistance		Thermal of	capacitance	·
R _{th1}	0.012	K/W	C _{th1}	0.0002495	Ws/K
R _{th2}	0.023		C _{th2}	0.0009406	
R _{th3}	0.043		C _{th3}	0.001298	7
R_{th4}	0.149		C _{th4}	0.00362	
R_{th5}	0.17		C _{th5}	0.009484	
R_{th6}	0.069		C _{th6}	0.077	





1 Power dissipation

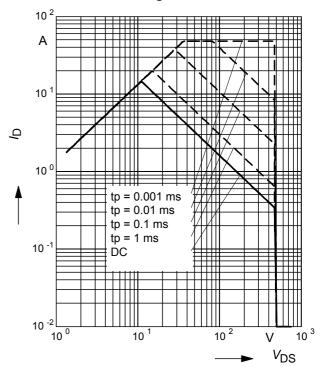
$$P_{\text{tot}} = f(T_{\text{C}})$$



2 Safe operating area

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

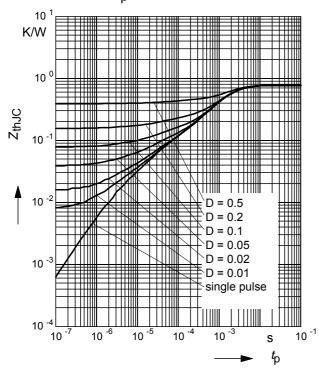
parameter : D = 0 , $T_C = 25$ °C



3 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_{\text{p}})$$

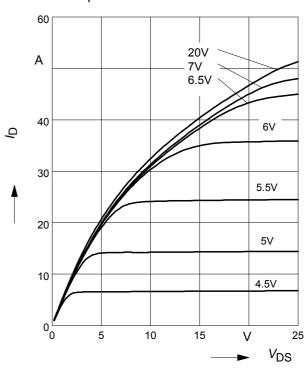
parameter: $D = t_D/T$



4 Typ. output characteristic

 $I_{D} = f(V_{DS}); T_{j}=25^{\circ}C$

parameter: t_p = 10 μ s, V_{GS}

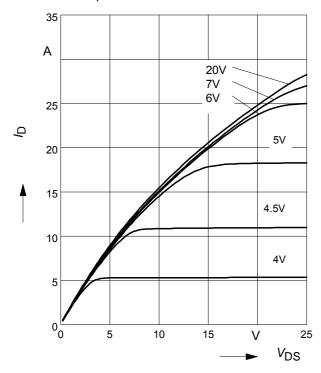


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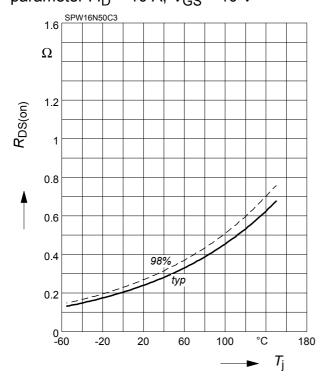
5 Typ. output characteristic

 $I_{D} = f(V_{DS}); T_{j}=150$ °C parameter: $t_{p} = 10 \mu s, V_{GS}$



7 Drain-source on-state resistance

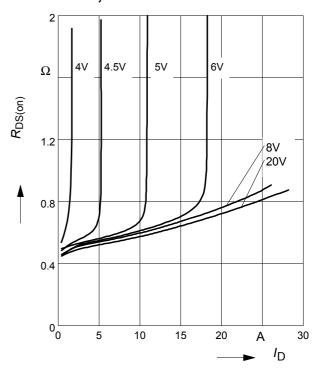
 $R_{\mathrm{DS(on)}} = f(T_{\mathrm{j}})$ parameter : $I_{\mathrm{D}} = 10 \,\mathrm{A}, \,V_{\mathrm{GS}} = 10 \,\mathrm{V}$



6 Typ. drain-source on resistance

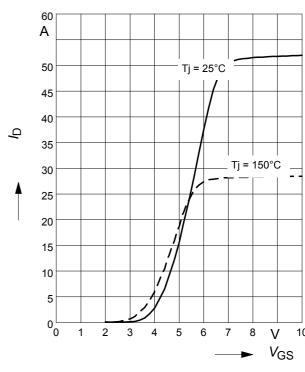
 $R_{DS(on)} = f(I_D)$

parameter: T_i =150°C, V_{GS}



8 Typ. transfer characteristics

 $I_{\rm D}$ = $f(V_{\rm GS})$; $V_{\rm DS}$ $\geq 2 \times I_{\rm D} \times R_{\rm DS(on)max}$ parameter: $t_{\rm p}$ = 10 μ s



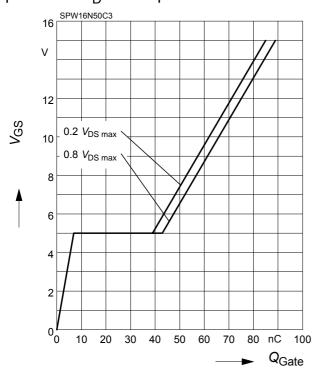
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9 Typ. gate charge

 $V_{GS} = f (Q_{Gate})$

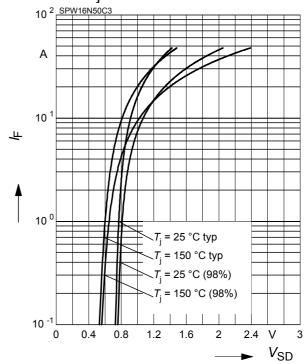
parameter: I_D = 16 A pulsed



10 Forward characteristics of body diode

 $I_{\mathsf{F}} = f(\mathsf{V}_{\mathsf{SD}})$

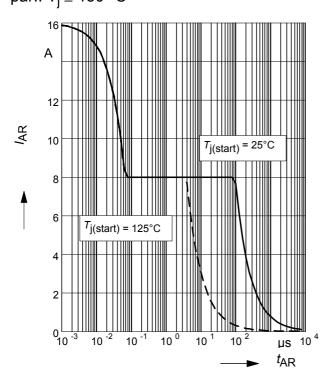
parameter: T_i , $tp = 10 \mu s$



11 Avalanche SOA

 $I_{AR} = f(t_{AR})$

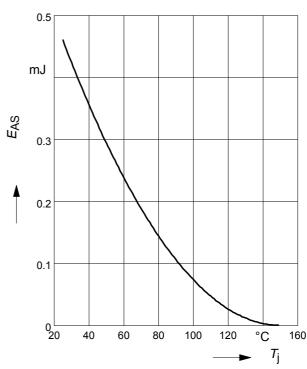
par.: $T_j \le 150 \,^{\circ}\text{C}$



12 Avalanche energy

 $E_{AS} = f(T_i)$

par.: $I_D = 8$, $V_{DD} = 50 \text{ V}$

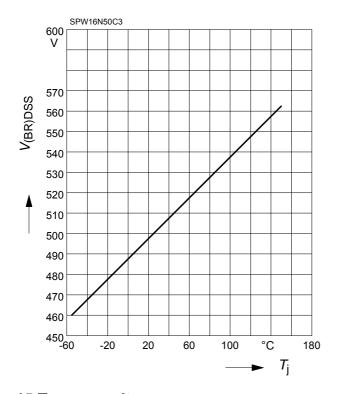


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13 Drain-source breakdown voltage

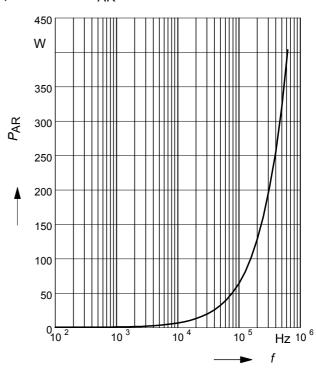
$$V_{(BR)DSS} = f(T_i)$$



14 Avalanche power losses

$$P_{AR} = f(f)$$

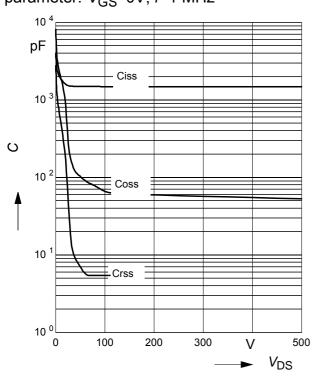
parameter: EAR=0.64mJ



15 Typ. capacitances

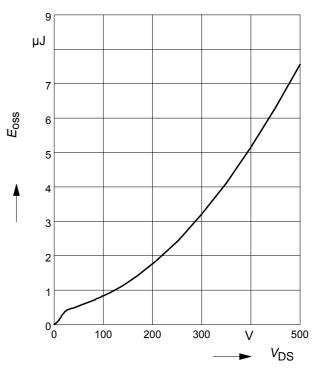
$$C = f(V_{DS})$$

parameter: V_{GS}=0V, f=1 MHz



16 Typ. $C_{\rm OSS}$ stored energy

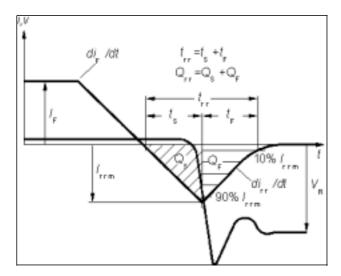
$$E_{\text{oss}} = f(V_{\text{DS}})$$



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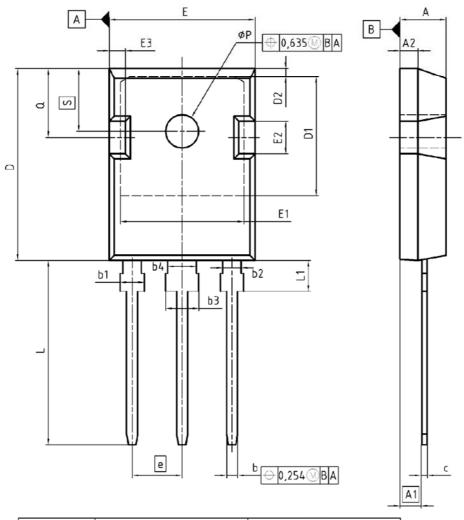


Definition of diodes switching characteristics

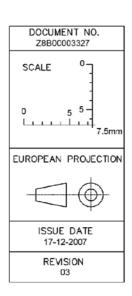




PG-TO-247-3-1



DIM	MILLIMETERS		INCH	IES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.16	0.193	0.203
A1	2.27	2.53	0.089	0.099
A2	1.85	2.11	0.073	0.083
ь	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
С	0.55	0.68	0.022	0.027
D	20.82	21.10	0.820	0.831
D1	16.25	17.65	0.640	0.695
D2	1.05	1.35	0.041	0.053
E	15.70	16.03	0.618	0.631
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.68	2.60	0.066	0.102
е	5.	44	0.2	:14
N	(3	(3
L	19.80	20.31	0.780	0.799
L1	4.17	4.47	0.164	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248





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New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

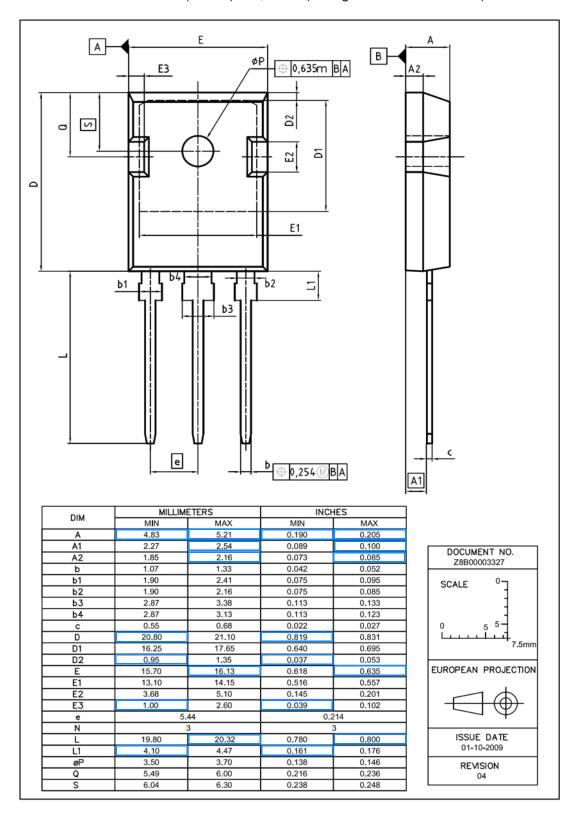


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum Rev. 2.0, 2010-02-01

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